## NOTES:

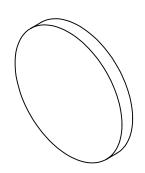
- 1. SUBSTRATE: UV FUSED SILICA
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 890 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 860nm @ 0° AOI T(abs): =50% FOR 875±8.75nm @ 0° AOI

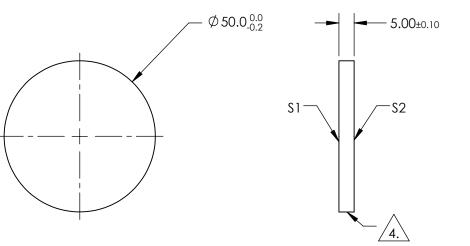
S2:SINGLE LAYER MgF2

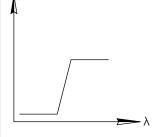
## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm (prior to coating)
- 7. ROHS COMPLIANT









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## SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

LONGPASS FILTER		_		Edmund Optics <sup>®</sup>	
	S1	\$2			
SHAPE	PLANO	PLANO			Ø50mm, 875nm, HIGH PERFORMANCE
SURFACE QUALITY	60-40	60-40		TITLE	LONGPASS FILTER
CLEAR APERTURE	>80%	>80%			
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	86079 SHEET 1 OF 1